

Flash Memory Cards

Highlights

- Complete turnkey services (wafer to card test)
- Mixed IC technology & SMT components
- Standard and green materials sets
- Multi-die, side-by-side & stacked

Features

- Body sizes up to 20 x 30mm
- Traditional IC packaging process flows
- Wafer backgrinding & polishing
- Surface mount technology
- Die stacking
- Die level & pre-packed memory supported
- Die attach with epoxy & film
- Wire bonding (traditional, reverse, FFL, etc.)
- Vacuum molding
- Laser & ink marking
- Singulation using blade, waterjet, edge grinder or laser
- Chamfering
- Lid attach using B-stage epoxy or ultrasonic welder
- Mechanical card assembly
- Label attach
- High speed integrated curve-cutting
- Lead-free & green materials set
- Memory & Final Test capabilities

Applications

- Digital still & video cameras
- Mobile handsets
- GPS devices
- PDAs, MP3 players, etc.



Description

We offer a variety of memory card formats in addition to value-added package assembly and test services. A majority of our card packaging processes are common with traditional packaging and leverage the most up-to-date technologies and processes unique to memory cards, including integrated curve-cutting, labelling, mechanical card assembly and card packaging.

We have solutions that utilize bare die level assembly, prepackaged die assembly or a combination of both. The Micro-SD is an example of an integrated solutions using NAND and controller die. In addition to assembly, we offer memory and card test services, with dedicated test resources to support test development as required.

Memory Card Formats

We offer tooling for the following memory card formats:

- SD Card
- Mini SD
- Micro SD
- Memory Stick
- MS Pro Duo
- MS Micro

Specifications

Die Thickness Gold Wire **SMT Components**

Bill of Materials **Packing Options** $60 - 355 \mu m$ (2.4 - 14mils) 0.6 - 1.3 µm diameter, 99.99% Au 0603, 0402, 0201, 01005, odd parts, x-tals, filters, LEDs, etc. Standard and lead-free

JEDEC tray or tape & reel

Reliability

Temperature Cycling -40°C ~125°C, 1000 cycles Thermal Shock -40°C ~80°C, 100 cycles

Unbiased HAST 130°C/85% RH/33.3psia, 100 hrs

150°C, 1000 hrs High Temperature Storage Low Temperature Storage -40°C, 168 hrs **Blend Test** 15N at center 5X

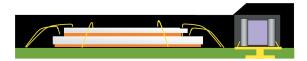
1.5m height, 6 surfaces Drop Test

Twist Test .5Nm torque, 5X CW, 5X CCW Salt Water Spray 3% NaCl @ 35°C, 24 hrs

Cross Sections



Micro SD-SiP



SD-SiP



Package Configurations

A variety of wirebond stacked die configurations are in production and under development. In addition, many standard package configurations can be integrated to address customer specific solutions.

